Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/693,605	INUI ET AL.	
Examiner	Art Unit	
Alain L. Bashore	1762	

SEARCHED				
Class	Subclass	Date	Examiner	
427	162, 163.2, 165	6/18/2007	AB	
430	321,394	6/18/2007	AB	
430	290	6/18/2007	ab	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	=	,		

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
EAST (attached)	6/18/2007	АВ
inventor and asignee search	6/18/2007	ab